Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/713,582	HOSHINO, YOSHIHIDE	
Examiner	Art Unit	
LUT TRAN	2853	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	102	6/19/2006	LT

INTERFERENCE SEARCHED		
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